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Elemental Characterization of Geological Materials Using Portable X-Ray Fluorescence (pXRF) Bruker S1 Titan 600

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Abstract

Portable X-Ray Fluorescence (pXRF) is widely used for rapid, non-destructive geochemical characterization of rocks and soils in laboratory and field applications. This study evaluates the working principles and analytical performance of the Bruker S1 Titan 600 portable XRF analyzer for rock-derived materials. Construction fill soil and iron sand samples collected from Aceh Province, Indonesia, were analyzed using the geominig calibration mode under controlled laboratory conditions with repeated measurements. The results show that Silicon (Si) was identified as the dominant element in construction fill soil with an average concentration of 33.7 wt%, while iron (Fe) is dominant in iron sand samples with concentrations above 70 wt%. The repeated measurements demonstrate good analytical repeatability for major elements, indicating that the instrument is suitable for preliminary geochemical classification and screening of geological materials.

1. Introduction

Geochemical characterization of rocks and soils is a fundamental process in mineral exploration, environmental monitoring, and geotechnical assessment (Nikolaos et al., 2026). Conventional analytical techniques such as Inductively Coupled Plasma–Optical Emission Spectroscopy (ICP-OES) and Atomic Absorption Spectroscopy (AAS) provide high analytical accuracy but require complex sample preparation and

laboratory-based analysis (Arthur et al, 2026). As an alternative, X-Ray Fluorescence (XRF) offers rapid, non-destructive, and multi-elemental analysis with minimal sample preparation, making it suitable for both laboratory and field applications.

Recent developments in portable XRF (pXRF) instrumentation have significantly improved detector resolution and analytical speed, enabling real-time geochemical screening during exploration activities. The Bruker S1 Titan 600, equipped with a Silicon Drift Detector (SDD), has been widely applied in geomining investigations due to its robustness, portability, and reliable elemental quantification of major and minor elements in geological materials (Vanhoof et al., 2021). The purpose of this study was to evaluate the working principle and analytical performance of the Bruker S1 Titan 600 portable X-Ray Fluorescence (pXRF) instrument in the geochemical analysis of rock-based materials. The evaluation was carried out through repeated measurements of construction fill soil and iron sand samples to assess the consistency of the results, the repeatability of the measurements, and the ability of the instrument to identify and classify materials based on the composition of major elements. Previous studies have demonstrated the capability of pXRF for rapid elemental analysis; however, variations in sample matrix, calibration method, and measurement conditions may affect the reliability of quantitative results (Jenkins et al, 2025). Therefore, evaluation of pXRF application for local geological materials is required to assess its suitability for preliminary characterization.

2. Theoretical Background

2.1 Principle of X-Ray Fluorescence

X-ray fluorescence (XRF) is an elemental analysis technique based on the interaction between high-energy X-rays and matter (Ferreira et al, 2026). When a material is irradiated with primary X-rays, inner-shell electrons of atoms may be ejected if the incident energy exceeds their binding energy (Souris et al, 2023). The resulting vacancies are filled by electrons from higher energy shells, leading to the emission of characteristic X-ray photons. The energies of these photons are unique for each element, allowing qualitative identification, while their intensities are proportional to elemental concentrations, enabling quantitative analysis (Gonzales et al, 2024).

2.2 X-Ray Generation in Bruker S1 Titan 600

In the Bruker S1 Titan 600 portable XRF analyzer, X-rays are generated using an X-ray tube equipped with a tungsten target (Evangelista, 2025). Electrons emitted from a heated filament are accelerated toward the anode under high voltage, producing X-rays upon impact. The generated radiation consists of bremsstrahlung radiation, which forms a continuous spectrum, and characteristic radiation resulting from electronic transitions within the target atoms. Tungsten is selected as the target material due to its high atomic number and high melting point, which ensure stable X-ray production under high thermal and electrical operating conditions (Yun et al, 2025).

2.3 Detection System: Silicon Drift Detector (SDD)

The Bruker S1 Titan 600 employs a Silicon Drift Detector (SDD), which provides high energy resolution and fast signal processing (Agostini et al, 2025). The SDD enables accurate discrimination between closely spaced elemental peaks, significantly improving analytical reliability compared to earlier proportional or PIN detectors (Magdy, 2023). This feature is crucial for complex geological matrices where spectral interferences are common.

2.4 Matrix Effects and Analytical Limitations

XRF measurements are influenced by matrix effects, including absorption and enhancement phenomena caused by the surrounding elemental composition (Turner et al, 2024). These effects can alter fluorescence intensities and introduce systematic errors. To minimize such influences, the Bruker S1 Titan 600 utilizes factory-calibrated algorithms and application-specific modes (e.g., geomining mode), which incorporate empirical and fundamental parameter corrections (Gao et al, 2026).

3. Materials and Methods

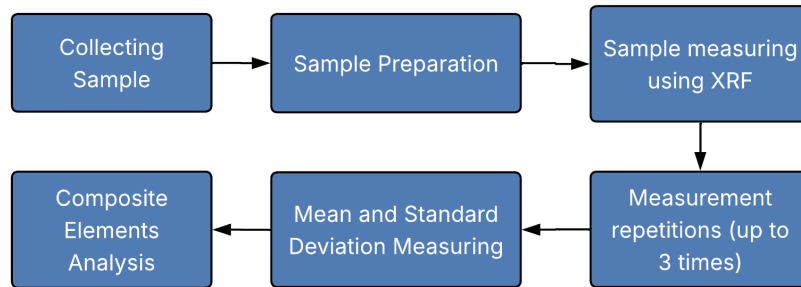


Figure 1. Research workflow and data analysis steps

3.1 Instrumentation

Elemental analyses were conducted using a Bruker S1 Titan 600 portable XRF analyzer equipped with an SDD detector and integrated Bruker Elemental Analysis Software. Measurements were performed in both laboratory (stationary) and field (handheld) configurations.

3.2 Sample Preparation

Rock-derived samples consisted of construction fill soil and iron sand collected from selected locations in Aceh Besar Regency, Aceh Province, Indonesia. Samples were air-dried to remove moisture and homogenized prior to analysis. No chemical treatment was applied, consistent with the non-destructive nature of XRF analysis.

3.3 Measurement Procedure

Samples were placed on the measurement window and shielded using the detector safety cover. The geomining calibration mode was selected, and each sample was measured three times with an acquisition time of approximately 60 seconds per measurement to evaluate precision and repeatability. Data processing was performed by calculating the mean value and standard deviation (SD) from three repeated measurements. The equations used are:

Mean:

$$\bar{x} = \frac{\sum x_i}{n} \quad (1)$$

Standard deviation:

$$SD = \sqrt{\frac{\sum (x_i - \bar{x})^2}{n - 1}} \quad (2)$$

4. Results and Discussion

4.1. Results

4.1.1. Elemental Composition of Construction Fill Soil

The results of the portable XRF analysis are presented to evaluate the elemental composition and measurement repeatability of construction fill soil samples. Three repeated measurements were conducted under identical conditions to assess analytical consistency. The elemental composition of construction fill soil obtained from Lamtadok, Aceh Besar, was analyzed using the Bruker S1 Titan 600 portable XRF analyzer in geominig mode. To evaluate measurement precision and repeatability, each sample was measured three times under identical laboratory conditions. The results of the XRF analysis are summarized in Table 1.

Tabel 1. Elemental composition of construction fill soil (Test 1) measured using Bruker S1 Titan 600

Element	Mean Concentration (%wt)	Standard Deviation (%wt)
Si	33.7	7.2
Al	8.5	0.5
Fe	6.6	0.5
Ca	4.1	0.2
Mg	2.8	0.2
K	2.0	0.2
Na	1.3	0.1
Mn	0.48	0.03
Cu	0.12	0.01
Zn	0.10	0.01

Silicon (Si) is the dominant element in the construction fill soil samples, with an average concentration of 33.7%wt, indicating the predominance of silicate minerals such as quartz and feldspar. Aluminum (Al) and iron (Fe) also show relatively high concentrations, reflecting the presence of aluminosilicate and iron-bearing mineral phases. The calculated standard deviations for major elements are relatively low compared to their mean values, suggesting good repeatability of the Bruker S1 Titan 600 measurements under laboratory conditions.

Minor elements such as Mn, Cu, and Zn exhibit low concentrations with small standard deviations, indicating stable detection performance despite their lower abundance. Overall, the statistical summary demonstrates that repeated pXRF measurements yield consistent elemental data, supporting the reliability of the instrument for rapid geochemical screening applications. The summarized statistical values presented in Table 4 provide a clear comparison of elemental abundances and measurement variability; therefore, additional graphical representation was considered unnecessary.

4.1.2. Instrument Configuration and Measurement Geometry

Figure 1 illustrates the main components of the Bruker S1 Titan 600, including the X-ray tube, Silicon Drift Detector (SDD), measurement window, and shielding system.



Figure 2. Main components of the Bruker S1 Titan 600 portable XRF analyzer

4.2 Discussion

The elemental composition results obtained using the Bruker S1 Titan 600 portable XRF demonstrate consistent detection of major elements in rock-derived samples; however, several analytical factors must be considered when interpreting the data. In pXRF analysis, measurement accuracy is influenced not only by instrumental performance but also by sample-related effects and physical limitations inherent to X-ray interactions.

In this study, silicon (Si) showed the highest concentration in construction fill soil with an average value of 33.7 wt% and a standard deviation of 7.2 wt%. The variation observed in Si measurement may be related to sample heterogeneity, mineral distribution, and particle size differences. Meanwhile, Fe and Al showed lower variations, indicating more stable detection during repeated measurements.

4.2.1. Sources of Analytical Error

Potential sources of error in pXRF measurements include surface heterogeneity, particle size variation, and sample positioning relative to the detector window. Because the analysis was performed without chemical digestion or pelletization, variations in grain size and surface roughness may cause localized differences in X-ray absorption and scattering. These effects can lead to minor fluctuations in measured elemental concentrations, particularly for elements present at low levels. Instrumental drift and counting statistics may also contribute to uncertainty; however, the low standard deviation values observed for major elements indicate that such errors are minimal under controlled laboratory conditions.

4.2.2. Matrix Effects in pXRF Analysis

Matrix effects play a significant role in XRF analysis, as the presence of multiple elements within a sample can influence both excitation efficiency and fluorescence yield. High concentrations of silicon and aluminum in the construction fill soil samples may result in absorption or enhancement effects that affect the detection of lighter or trace elements. In pXRF systems, these matrix interactions are partially corrected through factory calibration models, such as the geomining mode used in this study. Nevertheless, residual matrix effects may still influence quantitative accuracy, particularly for elements with overlapping spectral lines or low fluorescence energies.

4.2.3. Detection Limits of Portable XRF

The detection limits of pXRF instruments are generally higher than those of laboratory-based XRF or ICP-based techniques, especially for light elements and trace metals. In this study, major elements such as Si,

Al, Fe, Ca, and Mg were reliably quantified, while minor elements exhibited lower concentrations approaching the practical detection limits of the instrument. The stable detection of minor elements with low standard deviation suggests that the Bruker S1 Titan 600 is suitable for semi-quantitative to quantitative screening; however, for precise trace element analysis, complementary laboratory methods may be required.

4.2.4 Implications for Geological Screening Applications

Despite these limitations, the results confirm that pXRF provides a rapid and reliable tool for preliminary geochemical characterization. When combined with appropriate calibration modes and controlled measurement conditions, the Bruker S1 Titan 600 offers sufficient analytical performance for geological screening, material classification, and quality control purposes. Understanding the influence of analytical error sources, matrix effects, and detection limits is essential to ensure proper interpretation and responsible use of pXRF data in applied geoscience studies.

4.2.5 Portable XRF as an Effective Tool for Rapid Non-Destructive Elemental Analysis

Similar applications of portable XRF have been reported in previous studies, where the technique was used for rapid elemental identification of geological materials. Studies using instruments such as Bruker pXRF, Olympus Vanta, and Thermo Niton have shown that portable XRF is effective for preliminary mineral characterization, although laboratory-based techniques are still required for high-accuracy quantitative analysis.

5. Conclusion

This study demonstrates that the Bruker S1 Titan 600 portable X-ray fluorescence (pXRF) analyzer is an effective tool for rapid elemental analysis. The analysis identified silicon (Si) as the dominant element in construction fill soil with an average concentration of 33.7 wt% and a standard deviation of 7.2 wt%. Other major elements such as Al and Fe were also detected with relatively stable repeatability analysis of rock-derived materials under controlled laboratory conditions. The instrument successfully quantified major elements such as Si, Al, Fe, Ca, and Mg with good repeatability, as indicated by low standard deviation values from repeated measurements. The analysis confirms that pXRF is well suited for preliminary geochemical screening and material characterization, particularly for applications requiring fast data acquisition and minimal sample preparation. However, the interpretation of pXRF results must consider potential sources of analytical error, matrix effects, and instrument detection limits, especially when assessing minor and trace elements. Overall, the Bruker S1 Titan 600 provides reliable and consistent elemental data for geological screening purposes, while complementary laboratory-based techniques are recommended for detailed quantitative trace element analysis. Future studies should compare pXRF measurements with laboratory-based techniques such as ICP-OES or AAS to validate quantitative accuracy.

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Author Contributions

AF performed data analysis and prepared both the original and revised versions of the manuscript. MR contributed to the preparation of the original manuscript and its subsequent revisions.

References

- Agostini, G., Ambrosino, F., Antonelli, M., Aquilanti, G., Bellutti, P., Bertuccio, G., ... & Vacchi, A. (2025). Silicon drift detector monolithic arrays for X-ray spectroscopy. *Frontiers in Detector Science and Technology*, 3, 1551757.
- Arthur, R., Boateng, S. N., Bryant, I. M., Baidoo, M. F., & Scherer, P. A. (2026). Analytical Techniques for Heavy Metal Monitoring in Environmental Samples Related to Biogas Producing Systems: A Multi-Criteria Review. *Critical Reviews in Analytical Chemistry*, 1-20.
- Bruker Corporation. (n.d.). *Bruker enables*. Bruker Corporation.
- Bruker Corporation. (n.d.). *S1 TITAN Handheld XRF Analyzer: Technical Information*. Bruker Corporation.
- Evangelista Sánchez, N. (2025). Thermal Analysis of Tungsten Targets for High-Power X-ray Tubes.
- Ferreira, D. S., Silva, R. A., Pacheco, G. M., Pereira-Filho, E. R., & Pereira, F. M. V. (2026). A review of multivariate modelling for x-ray fluorescence techniques. *Chemometrics and Intelligent Laboratory Systems*, 271, 105663.
- Gao, L., Zhang, C., & Sun, R. (2026). X-Ray Fluorescence Spectrometry in Botanical Drugs' Research-Applications, Methodologies, and Future Perspectives. *Critical Reviews in Analytical Chemistry*, 1-19.
- Gonzalez, M. F., Saadatkhah, N., & Patience, G. S. (2024). Experimental methods in chemical engineering: X-ray fluorescence—XRF. *The Canadian Journal of Chemical Engineering*, 102(6), 2004-2018.
- Jenkins, E. M., Galbraith, J., & Paltseva, A. A. (2025). Portable X-ray fluorescence as a tool for urban soil contamination analysis: accuracy, precision, and practicality. *Soil*, 11(2), 565-582.
- Magdy, M. (2023). X-ray techniques dedicated to materials characterization in cultural heritage. *ChemistrySelect*, 8(33), e202301306.
- Nikolaos, A., Panagiotis, K., & Pavlos, A. (2026). From Geology to Robotics: A Review of Next-Generation Autonomous Drilling Technologies for Critical Mineral Exploration. *Geosciences*, 16(4), 139.
- Souris, J. S., Leoni, L., Zhang, H. J., Pan, A., Tanios, E., Tsai, H. M., ... & Chen, C. T. (2023). X-ray activated nanoplateforms for deep tissue photodynamic therapy. *Nanomaterials*, 13(4), 673.
- Turner, K. E., & Webber, E. (2024). GGR Handbook of Rock and Mineral Analysis Chapter 6 (Part 1) Principles and Practice of X-Ray Fluorescence Spectrometry—1: Fundamentals of XRF and Matrix Corrections. *Geostandards and Geoanalytical Research*, 48(3), 505-541.
- Vanhoof, C., Bacon, J. R., Fittschen, U. E., & Vincze, L. (2021). Atomic spectrometry update—a review of advances in X-ray fluorescence spectrometry and its special applications. *Journal of Analytical Atomic Spectrometry*, 36(9), 1797-1812.
- Yun, H., Bae, L. J., Mirzaie, M., & Kim, H. T. (2025). Laser-plasma-based radiation sources with intense laser pulses. *Reviews of Modern Plasma Physics*, 9(1), 13.